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Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				<b>Complete if Known</b>	
				Application Number	NEW
				Filing Date	May 18, 2006
				First Named Inventor	Yoshikazu SAKAI
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	1560-0454PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
	AA*	US-2002/0036646-A1	03-28-2002	TOBIYA	
	AB*	US-6,188,380-B1	02-13-2001	KAWASHIMA et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				
	BA	JP-10-222129-A	08-21-1998			ABS
	BB	JP-9-43569-A	02-14-1997			ABS
	BC	JP-2000-315594-A	11-14-2000			ABS
	BD	JP-2002-99238-A	04-05-2002			ABS
	BE	JP-2002-162937-A	06-07-2002			ABS
	BF	JP-5-8000-U	02-05-1997			ABS

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	CA	Noriyuki HASHIMOTO, Japanese Journal of Radiological Technology, 2002, 1297-1302, 58-10.	Par. Trans.

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Examiner Signature	/Benyam Ketema/	Date Considered	04/07/2009
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CG/dns

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